

Search Notes 	Application/Control No. 10/658,275	Applicant(s)/Patent under Reexamination HICKEY ET AL.
	Examiner Dah-Wei D. Yuan	Art Unit 1745

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
429	12	7/31/2006	DWY
429	30	7/31/2006	DWY
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